Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/696,790	SHIH ET AL.	
Examiner	Art Unit	•
Josep M. Croope	1724	

SEARCHED						
Class	Subclass	Date	Examiner			
55	282./ 282.2 282.3 282.4	8/29/65	Pap			
55	385.1					
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55	490,490.1					
55	502,503					
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55	016.10 pEG.30					
95	278, 283	I I				
96	225					
422	180					
60	273,282					
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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(INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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